Electrical properties of YSZ/NiO composites prepared by a liquid mixture technique

V. Esposito, E. Traversa
Dipartimento di Scienze e Tecnologie Chimiche, Università di Roma "Tor Vergata", Via della Ricerca Scientifica, 00133, Roma, Italy

D. Z. de Florio*, F. C. Fonseca, E. N. S. Muccillo, R. Muccillo
CCTM-Instituto de Pesquisas Energéticas e Nucleares CP 11049, 05422-970, S. Paulo, SP, Brazil

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Abstract

We report the preparation and characterization of yttria-stabilized zirconia/nickel oxide composites (YSZ/NiO). This composite is the precursor material for the cermet YSZ/Ni, which is used as solid oxide fuel cell (SOFC) anode after the reduction of the NiO. The performance of the anode material is strongly dependent on the microstructural properties of the cermet. Therefore, the control of the microstructure of the YSZ/NiO composite is a key step for the fabrication of high-performance anode cermets. In this study, the composites were prepared by a modified liquid mixture technique in the concentration range of 0-75 mol% of NiO, followed by calcination at 450

* Present address: LIEC, IQ, UNESP, Araraquara/SP, Brazil
°C. The powders were investigated by scanning electron microscopy and X-ray diffraction (XRD) analysis, which evidenced the good dispersion of the phases and that NiO nanoparticles are spread over the YSZ surface. Dense pellets sintered at 1350 °C were studied by XRD and electrochemical impedance spectroscopy in the 100-800 °C temperature range. The main results show that the composite is comprised of a well-dispersed mixture of the two phases, and no solubilization of the NiO into YSZ structure was detected. The electrical conductivity data show that there is a strong dependence of the transport mechanism on the relative composition of phases.

Keywords: mixed conductor, composite, electrical properties

I. Introduction

There has been a considerable interest on the electrical behavior of composite media due to both the intriguing observed properties and the technological applications.\(^1\) The possibility of tailoring the properties by controlling the relative volume fraction of phases for specific applications is an important aspect regarding composite materials. In addition to the electrical properties of each phase, the properties of composites are strongly influenced by the microstructural features such as grain size, distribution, and morphology.\(^2\) In fact, some unusual properties have been reported regarding the electrical properties of composites formed by the mixture of two phases with different charge carrier species. An example is the decrease of the electrical conductivity ($\sigma$) by the addition of Ni in the NiO matrix.\(^3\) Some models like percolation, effective media, and space-charge layers have been applied to account for the observed electrical behavior.
Moreover, the nature of the charge carriers and the dependence of $\sigma$ on the microstructure, temperature, and oxygen partial pressure can be considered as important parameters for electrochemical applications.

Several applications such as fuel cell electrodes, sensors, electrocatalytic reactors, and gas separation membranes, have attracted the attention to mixed conductors. These materials exhibit both electronic and ionic species as charge carriers and can be either single-phase or composite. For example, in a solid oxide fuel cell (SOFC) the electrode materials are mixed conductors. Usually, in the SOFC anode, the desired mixed conductivity and electrocatalytic activity are achieved by mixing an ionic conductor (yttria-stabilized zirconia) and a metal (nickel). The use of nickel is due to its high electrical conductivity and catalytic activity under reducing conditions, while YSZ provides an ionic pathway for $\text{O}^{2-}$, enhances the match of the thermal expansion coefficients, and inhibits the sintering of the metallic particles. The electrochemical activity of the electrodes increases with increasing reaction area, called triple phase boundaries (TPB). Therefore, the length of the TPB depends on both the chemical composition and the microstructure of the electrode. In addition, it is necessary to have well-dispersed nickel particles in a continuous network to provide electronic transport to the external circuit. The anode composite is usually fabricated by a heat treatment of the yttria-stabilized zirconia/nickel oxide composite (YSZ/NiO) precursor in a reducing atmosphere. The stoichiometric NiO is an insulator, however, due to composition deviations it assumes a p-type semiconductor behavior, where the electron holes are created by Ni vacancies.
Thus, in order to obtain high-performance anode materials it is important to control the parameters during the synthesis of the precursor composite. In the present work, we have investigated the precursor material for SOFC anodes prepared by a modified liquid mixture technique in a wide relative concentration range of the phases. The electrical conductivity of the YSZ/NiO composite was studied by means of impedance spectroscopy measurements up to 800 °C. The main results indicate that the electric properties are strongly influenced by the relative composition and three different transport mechanisms were found through the analysis of the electrical conductivity data.

II. Experimental

Composite samples of (1-m)(ZrO$_2$:8 mol% Y$_2$O$_3$)/mNiO (YSZ/mNiO), with m ranging from 0 to 75 mol%, were prepared by a modified liquid mixture technique, which was found to produce powders with homogenous phase distribution. This process consists in the evaporation of a dispersion of YSZ (Tosoh) powder in a solution of nickel acetate (tetrahydrate, Carlo Erba) and ethanol. The liquid mixture was held in ultrasonic bath for 1 h and heated on a hot plate under vigorous stirring to evaporate the ethanol. The prepared powder was dried at 80 °C and calcinated in air at 450 °C for 5 hours. This is the optimal temperature for the removal of organic material, as inferred by simultaneous thermogravimetric-differential thermal analysis. This method results in nanosized NiO particles spread on the YSZ surface, as revealed by scanning electron microscopy analysis. Cylindrical pellets were fabricated by uniaxial pressing and sintering at 1350 °C for 1 h. The sintered samples were analyzed by X-ray diffraction
(XRD) in a Bruker-AXS D8 Advance diffractometer at room temperature using CuKα radiation in the 20≤θ(°)≤85 range. The electrical properties of the composite samples were studied by means of impedance spectroscopy \( Z(\omega,T) \) measurements carried out from 100 to 800 °C in the 5 Hz-13 MHz frequency range with an applied excitation signal of 200 mV. In all \( Z(\omega,T) \) measurements, Ag contact pads were painted on the parallel surface of samples and cured at 400 °C.

### III. Results and discussion

The relative densities of the specimens were determined by the Arquimedes method. The theoretical densities (TD) were calculated by the rule of mixtures considering the nominal volume fraction and reported densities of the two oxides. The results show that sintering at 1350 °C for 1 h resulted in samples with high relative density (≥96% of the TD) in the whole studied concentration range.

The XRD analysis of the YSZ/mNiO samples revealed that all the observed peaks belong to the cubic phases of stabilized-zirconia and nickel oxide, as shown in Fig.1. Increasing the NiO molar content \( m \), increases the intensity of the corresponding diffraction peaks, which can be identified even for the lowest concentration \( m=5 \text{ mol%} \). In addition, the XRD patterns revealed the absence of extra reflections belonging to any additional phase in samples. The calculated YSZ lattice parameters were found to be in agreement with previously reported data and no significant dependence on the NiO content was observed, as shown in the inset of Fig.1. The formation of a solid solution between YSZ and NiO would significantly decrease the cubic zirconia lattice parameter.
due to the smaller ionic radius of $\text{Ni}^{2+}$ in comparison to both the $\text{Zr}^{4+}$ and $\text{Y}^{3+}$.\textsuperscript{9} These results suggest that the samples are comprised of a mixture of the two oxides and no appreciable solubilization of $\text{Ni}^{2+}$ into the cubic zirconia was detected within the resolution of the XRD technique. It was already reported that the NiO solubility limit in the cubic zirconia structure is $\leq 5$ mol% for samples sintered at 1600 °C for 4 h.\textsuperscript{10} In the present work, both the lower sintering temperature and time are believed to inhibit the solid solution formation between the two phases.

The $Z(\omega,T)$ data (not shown) reveal at least two semicircles in the whole frequency and temperature ranges studied. However, in this study we focus on the total electrical resistance of the YSZ/mNiO composite, which was obtained by fitting the low-frequency end of the impedance diagrams.

The NiO content dependence of the total electrical conductivity $\sigma(T)$ (Fig.2) showed that increasing the semiconductor content has a strong effect on the transport properties of the composite. For low $m$ values ($m \leq 10$ mol%), a slight increase of $\sigma(T)$ is observed at low measuring temperatures. Such a feature is a further indication that no $\text{Ni}^{2+}$ is dissolved into the cubic zirconia structure. The formation of solid solution would be expected to decrease the electrical conductivity of the YSZ due to defect interactions, since that the 8 mol% YSZ is within the optimal stabilizer content range for maximum $\sigma$.\textsuperscript{11} The $\sigma(T)$ data also reveal that increasing $m$ results in larger magnitudes of $\sigma(T)$ and that such a feature is much more pronounced at low temperatures ($T < 500$ °C). It was already reported that even small additions of NiO to YSZ generates appreciable electronic current.\textsuperscript{12} In fact, at $T = 190$ °C, a three orders of magnitude increase of $\sigma$ is observed for intermediary $m$ values, changing from $\sim 10^{-7}$ $(\Omega \text{cm})^{-1}$ for the YSZ to $\sim 5 \times 10^{-3}$
(Ωcm)$^{-1}$ for $m=45$ mol%. This pronounced increase of $\sigma(T)$ is related to the increasing electronic charge carriers with increasing NiO content and indicates that the percolation threshold is achieved at $m \approx 30$ mol% ($\sim 17$ vol%). This value is consistent with the theoretical critical volume fraction for the percolation of a metallic phase in an insulating matrix.\(^2\) However, further increasing the NiO content results in a downturn of the $\sigma(T)$ ($m>45$ mol%) and for $m=75$ mol% $\sigma(190^\circ\text{C}) \sim 10^{-6}$ (Ωcm)$^{-1}$. Thus, three different NiO concentration regions can be identified: (1) $m<20$ mol%; (2) $20 \leq m \leq 60$; and (3) $m>60$ mol%. These regions indicate that distinct transport mechanisms take place depending on the NiO content. In region (1) the main charge carriers are the oxygen ions, further increasing the NiO content (region 2) a mixed conduction process is more likely to occur, and in region (3) the main charge carriers may be the electron holes of NiO and YSZ grains act as insulating scattering centers. Similar NiO concentration ranges were defined for the ionic (region 1), mixed (region 2) and electronic (region 3) transport in a previously reported work.\(^{12}\) However, in that study, the higher sintering temperature promoted the solubilization of NiO into the YSZ, and both the mixed and electronic conduction regions are attained at slightly higher NiO concentrations. This is probably related to microstructural differences arising from the fabrication methods. As a result of the liquid mixture method, our samples have a better homogeneity than the ones prepared by the solid state reaction. Such a feature allows for the interconnection of NiO particles at lower concentrations and results in considerably higher $\sigma$ values at low temperatures. With increasing temperature, the dependence of the $\sigma(T)$ on the NiO content is less pronounced, and $\sigma(T)$ values have the same order of magnitude in the composition range investigated, as observed in Fig.2.\(^{12}\) The $\sigma(T)$ data of the YSZ/mNiO
composites reflects the higher electrical conductivity of NiO at lower temperatures (T<500 °C). In addition, due to the higher activation energy of the ionic conductor phase, the YSZ/mNiO σ values are comparable at higher temperatures. This is an indication that the activation process of the electrical conduction is also modified by the NiO addition.

In fact, the electrical resistivity ρ(T) behavior was found to follow Arrhenius-type activated processes, as shown in Fig.3. For YSZ/mNiO specimens with m<20 mol% (region 1), a thermally activated process is observed with activation energy ΔE close to the YSZ (ΔE~1 eV). For intermediary NiO compositions (region 2), a clear discontinuity of the Arrhenius behavior is observed at T~250 °C, a temperature found to be NiO-concentration independent. In order to describe the ρ(T) curves of the NiO compositions 20≤m≤60 curves, two Arrhenius processes were used. Further increasing the NiO content (m>60 mol%), results in a single thermally activated process, with lower ΔE values.

Assuming thermally activated processes, the ΔE for both temperature ranges were determined for the YSZ/mNiO specimens, as shown in Fig.4. In the composition region (1), even a small amount of the semiconductor phase significantly decreases the ΔE of the pure YSZ (0.98±0.02 eV) to ΔE=0.65±0.01 eV for the m=10 mol% specimen.\textsuperscript{13} This constitutes a further evidence that the NiO addition enhances electronic transport in YSZ/NiO. With increasing NiO content (region 2), two ΔE are found. For T<250 °C, the obtained values are close to ΔE~0.7 eV, and for T>250 °C the ΔE~0.3 eV. Specimens with higher concentrations of NiO (region 3) have ΔE~0.6 eV. These results are consistent with previous reported ΔE values for the electric conduction of the NiO. This
oxide is known to have $\Delta E=0.6$ eV for temperatures below $T \sim 500$ °C, and $\Delta E=0.3$ eV for $500 \leq T$ (°C) $\leq 900$. Thus, the estimated $\Delta E$ dependence on the NiO content provides further evidence that the transport mechanisms in the NiO concentration regions (1), (2), and (3) are due to ionic, mixed, and electronic charge carriers, respectively.

In summary, we have fabricated YSZ/NiO composites by a liquid mixture method, which resulted in homogenous powders with good sinterability. The relatively low sintering temperature inhibited the solid solution formation between the two oxides. Specimens with different NiO content exhibited different electrical conductivity behavior and thermal activation energies. The NiO concentration ranges where the main charge carriers are ionic, mixed, and electronic were estimated. The effectiveness of the described preparation method is evidenced by the high measured values of both the relative density and the electrical conductivity of the composites, indicating that this is a suitable method for the fabrication of precursors for SOFC anodes.

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References


Figure Captions

FIG. 1: X-ray diffraction patterns of (1-m) (ZrO$_2$:8 mol% Y$_2$O$_3$) / m NiO samples. The * and + symbols indicate the YSZ and NiO diffraction peaks, respectively. The inset shows the calculated lattice parameter of cubic YSZ.

FIG 2: NiO content dependence of the electrical conductivity of (1-m) (ZrO$_2$:8 mol% Y$_2$O$_3$) / m NiO composite measured at different temperatures. The lines are guide for the eye.

FIG 3: Arrhenius plots for the (1-m) (ZrO$_2$:8 mol% Y$_2$O$_3$) / m NiO composites.

FIG 4: Activation energy dependence on the NiO content of (1-m) (ZrO$_2$:8 mol% Y$_2$O$_3$) / mNiO composites.